## Laser-induced Damage Threshold (LIDT) in Optical Components



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#### What is Laser-induced Damage ?

Ü Laser-induced Damage (LID) is damage caused to an optical coating or substrate when irradiated by a Laser.

Ü As early as 1962 McClung and Hellwarth ('Giant Optical Pulsation from Ruby') reported that 'output light burned holes in the silvered surfaces' of their ruby rod.

Ü Since then, the power available from Laser has increased substantially and we are now regularly dealing with Petawatt lasers!



## The Basics

- Ü The Laser-induced Damage Threshold (LIDT) of optical materials is determined mainly by the following:
  - Ü Beam size (the more power is concentrated in one spot the more likely the damage)
  - Ü The Beam shape (Gauss / Supergauss this will be examined in more detail later)
  - Ü The Beam quality (hot-spots)
  - Ü The coating / substrate materials (metals vs. dielectrics, coating and substrate quality)
  - Ü The environment (cleanroom vs. dusty environment)



#### LID in common substrate materials

Ü Commonly used optical substrate materials incur LID due to the following

- Ü Dielectric breakdown (Fused Silica, Diamond, Quartz, Sapphire)
- Ü Thermal absorption (LiNbO<sub>3</sub>, BK7)

| Material                                   | LIDT @ 1064nm in J/cm <sup>2</sup> |  |  |
|--|------------------------------------|--|--|
| Fused Silica                               | 1.1 x 10 <sup>7</sup>              |  |  |
| Sapphire (Al <sub>2</sub> O <sub>3</sub> ) | 7 x 10 <sup>6</sup>                |  |  |
| Diamond                                    | 6 x 10 <sup>7</sup>                |  |  |
| LiNbO <sub>3</sub>                         | 5 x 10 <sup>4</sup>                |  |  |
| BK7  | 4 x 10 <sup>5</sup>                |  |  |

#### LID in optical coatings

Metal coatings predominantly damage as a result of thermal absorption

U Dielectric coatings generally show much lower absorption than metal coatings and defect-induced damage is more common. Ü Defects can be inclusions (dust particles) Ü The substrate surface can encourage irregular growth of coating layers, leading to defects Ü The coating parameters (deposition rate etc.) influence the quality of the coating.



#### How to scale LIDT

Ü For any given LIDT (LIDT( $t_1$ )) at a pulse duration  $t_1$ , the approximate LIDT (LIDT( $t_2$ ) at pulse duration  $t_2$  is given by

### LIDT $(t_2) = LIDT (t_1) * (t_2/t_1)^{1/2}$

# Ü This rule works for pulse durations of approx. 1ns – 20ns.

#### Coating designs for high LIDT requirements

U In general, optical coatings made of 'single stacks', i.e. stacks of high- and low index coating materials of lambda/4 optical thickness, display the highest LIDT.

U The choice of optical coating materials (and the deposition parameters) are important.



Ü Mero et al (Phys Rev B71, 115109) have undertaken fundamental work to estimate the LIDT (critical fluence) of a material as a function of the pulse duration and material band gap. For Formula see next slide.

Ü Interestingly, they could not establish any relationship between LIDT and defects or impurities due to the manufacturing process. (confirmed by Stolz et al.)



 $F_{th} = (C_1 + C_2 E_q) \tau_p^{\kappa}$ 

F<sub>th</sub>: critical fluence

E<sub>g</sub>: material band gap

 $\tau_p$ : pulse duration

κ: material specific constant

 $c_1$ : empirical factor, -0.16+/-0.02 J/cm<sup>2</sup>fs<sup>- $\kappa$ </sup>

c<sub>2</sub>: empirical factor, 0.074+/-0.004 J/cm<sup>2</sup>fs<sup>-</sup> keV<sup>-1</sup>



| Material                       | n <sub>800</sub><br>(refractive<br>index at<br>800nm) | E <sub>0</sub> (band gap<br>energy) | К           | Theoretical<br>critical<br>fluence in J/<br>cm2 for 15fs<br>pulse |
|--------------------------------|---|-------------------------------------|-------------|---|
| TiO <sub>2</sub>               | 2.39  | 3.3 eV                              | 0.28+/-0.02 | 0.18  |
| Ta <sub>2</sub> O <sub>5</sub> | 2.17  | 3.8 eV                              | 0.33+/-0.02 | 0.30  |
| HfO <sub>2</sub>               | 2.09  | 5.1 eV                              | 0.30+/-0.01 | 0.49  |
| $AI_2O_3$                      | 1.65  | 6.5 eV                              | 0.27+/-0.01 | 0.67  |
| SiO <sub>2</sub>               | 1.5   | 8.3 eV                              | 0.33+/-0.01 | 1.11  |



Source: Mero et al, Phys. Rev. B71, 115109 (2005)

Ü More recent work by Mangote et al (Optics Letters 37,9 1478, May 2012) looked into the relationship between the material's refractive index and its LIDT

- Ü Unfortunately, data was compiled for a 500fs pulse at 1030nm
- Ü The empirical law they found is:

 $LIDT = 12/n^2 J/cm^2$ 



Ü While the authors are unable to give a scientific explanation for this equation it highlights a significant implication for coating design.

Ü The LIDT appears to decrease by a power of two with increasing refractive index !!!



Ü 'Single Stack' coatings display a high LIDT and good Group Delay Dispersion (GDD).

Ü Spectral breadth is limited by ratio of refractive index between the 2 coating materials.

Ü 'Natural' limit on achievable breadth.



Performance shown under AOI of 45deg , p-POL





- Ü Stack 1 (n(H)/n(L)=1.365) is compatible with high power
- Ü Stack 2 (n(H)/n(L)=1.434) can only handle medium to low power
- Ü Bandwidth of at least 750-850nm is required by most customers
- Ü What can be done?



#### Solution 1: Combination of both stacks



#### Performance shown under AOI of 45deg, p-POL

Good and easy solution, BUT:

- **Ü** Potentially problematic under vacuum (stress can cause crazing of the coating, especially for larger substrates
- **Ü** Design can cause spikes in GDD
- Cannot handle spectral Supergauss beamprofiles well (Low LIDT) Ü



- Ü MPO's solution optimised design
- Ü High LIDT, vacuum compatible (even for large substrates), low GDD, can be tailored to customer requirements.



Performance shown under AOI of 45deg , p-POL

# Any Questions ?

